

Search Notes

Application/Control No.

09/825,397

Examiner

Hanh Nguyen

Applicant(s)/Patent under
Reexamination

CHANG, LEON F.

Art Unit

2668

SEARCHED

Class	Subclass	Date	Examiner
370	400	10/11/2005	HN
	389		
	314		
	356		
	401		
	395.5		
	395.53		
	395.6		
	395.61		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	395.6	10/5/2005	HN
	352		
	401		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	10/5/2005	HN